N-channel TrenchPLUS standard level FET

Rev. 05 — 16 February 2009

Product data sheet

1. Product profile

1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. The devices include TrenchPLUS current sensing and diodes for ElectroStatic Discharge (ESD) protection and temperature sensing. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

1.2 Features and benefits

- Allows responsive temperature monitoring due to integrated temperature sensor
- Electrostatically robust due to integrated protection diodes

1.3 Applications

Quick reference

Table 1

- Automotive and general purpose power switching
- Electrical Power Assisted Steering (EPAS)

1.4 Quick reference data

- Low conduction losses due to low on-state resistance
- Q101 compliant
- Reduced component count due to integrated current sensor
- Fan control
- Variable valve timing for engines

	QUICK TETETETICE					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	-	40	V
I _D	drain current	$V_{GS} = 10 \text{ V}; T_{mb} = 25 \text{ °C}; \text{ see } \frac{\text{Figure 2}}{\text{Figure 3}};$ [1]	-	-	155	А
Static cha	racteristics					
R _{DSon}	drain-source on-state resistance	V_{GS} = 10 V; I_D = 50 A; T_j = 25 °C; see Figure 7; see Figure 8	-	4.7	6	mΩ
I _D /I _{sense}	ratio of drain current to sense current	T _j > -55 °C; T _j < 175 °C; V _{GS} = 10 V	585	615	645	
$S_{F(TSD)}$	temperature sense diode temperature coefficient	I _F = 250 μA; T _j > -55 °C; T _j < 175 °C	-1.4	-1.54	-1.68	mV/K
V _{F(TSD)}	temperature sense diode forward voltage	I _F = 250 μA; T _j = 25 °C	648	658	668	mV

[1] Current is limited by power dissipation chip rating.



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2. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		5.1
2	ISENSE	Current sense	mb	D A
3	А	anode		┃ _{┣━} ╋ <u>┑</u> ┃┃
4	D	drain		G_↓↓↓←→↓↓↓
5	К	cathode		
6	KS	Kelvin source	123 567	
7	S	source	SOT427	
mb	D	mounting base; connected to drain	(D2PAK)	l _{sense} S ∣ K Kelvin source <i>sym110</i>

3. Ordering information

Table 3.Ordering information

Type number	Package		
	Name	Description	Version
BUK7C06-40AITE	D2PAK	plastic single-ended surface-mounted package (D2PAK); 7 leads (one lead cropped)	SOT427

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4. Limiting values

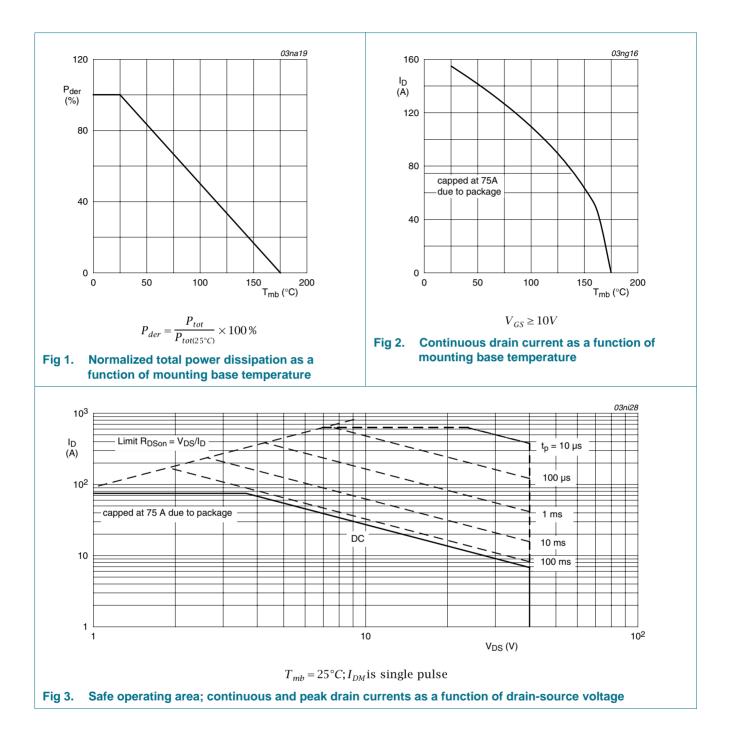
Table 4.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	40	V
V _{DGR}	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$		-	40	V
V _{GS}	gate-source voltage				20	V
I _D	drain current	$T_{mb} = 25 \text{ °C}; V_{GS} = 10 \text{ V}; \text{ see } Figure 2; \text{ see } Figure 3$	[1]	-	155	А
			[2]	-	75	А
		T_{mb} = 100 °C; V_{GS} = 10 V; see <u>Figure 2</u>	[2]	-	75	А
I _{DM}	peak drain current	T_{mb} = 25 °C; $t_p \le 10 \ \mu$ s; pulsed; see <u>Figure 3</u>		-	620	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 1</u>		-	272	W
I _{GS(CL)}	gate-source clamping	continuous		-	10	mA
	current	pulsed; $t_p = 5 \text{ ms}; \delta = 0.01$		-	50	mA
V _{isol(FET-TS} D)	FET to temperature sense diode isolation voltage			-100	100	V
T _{stg}	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
Source-dra	ain diode					
ls	source current	T _{mb} = 25 °C	[1]	-	155	А
			[2]	-	75	А
I _{SM}	peak source current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$		-	620	А
Avalanche	ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$ I_D = 75 \text{ A}; \text{V}_{sup} \leq 40 \text{ V}; \text{R}_{GS} = 50 \Omega; \text{V}_{GS} = 10 \text{ V}; \\ \text{T}_{j(\text{init})} = 25 ^\circ\text{C}; \text{ unclamped} $		-	1.46	J
Electrostat	tic discharge					
V_{esd}	electrostatic discharge voltage	HBM; C = 100 pF; R = 1.5 k Ω		-	6	kV

[1] Current is limited by power dissipation chip rating.

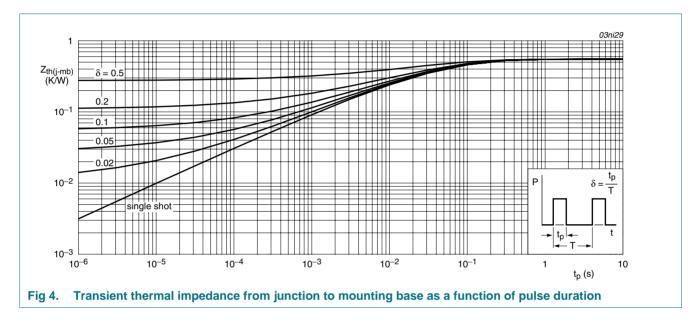
[2] Continuous current is limited by package.



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5. Thermal characteristics

Table 5.	Thermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-a)}	thermal resistance from junction to ambient	mounted on printed-circuit board; minimum footprint	-	-	50	K/W
R _{th(j-mb)}	thermal resistance from junction to mounting base	see Figure 4	-	-	0.55	K/W

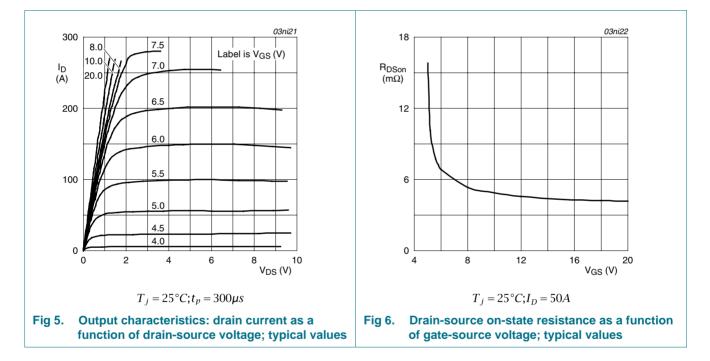


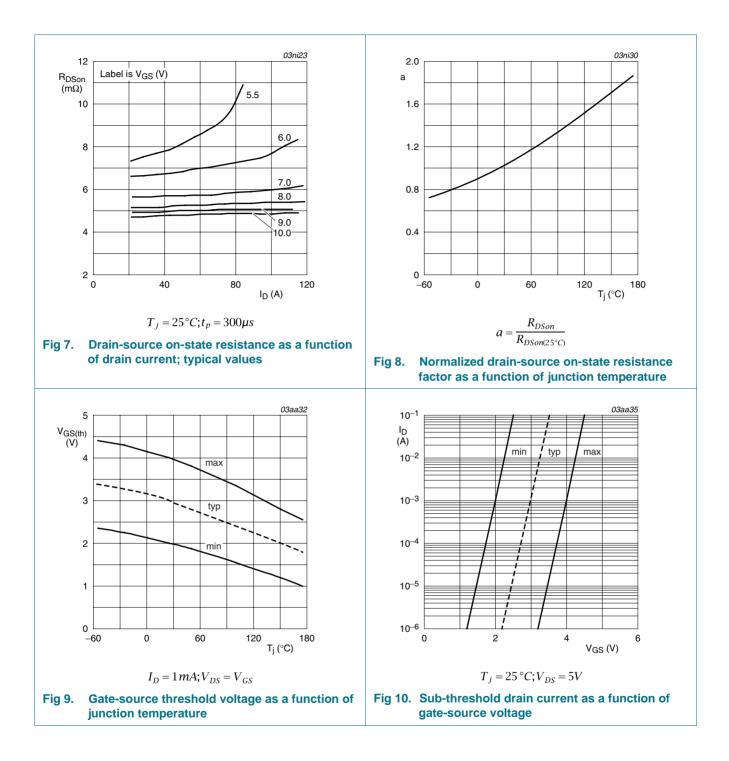
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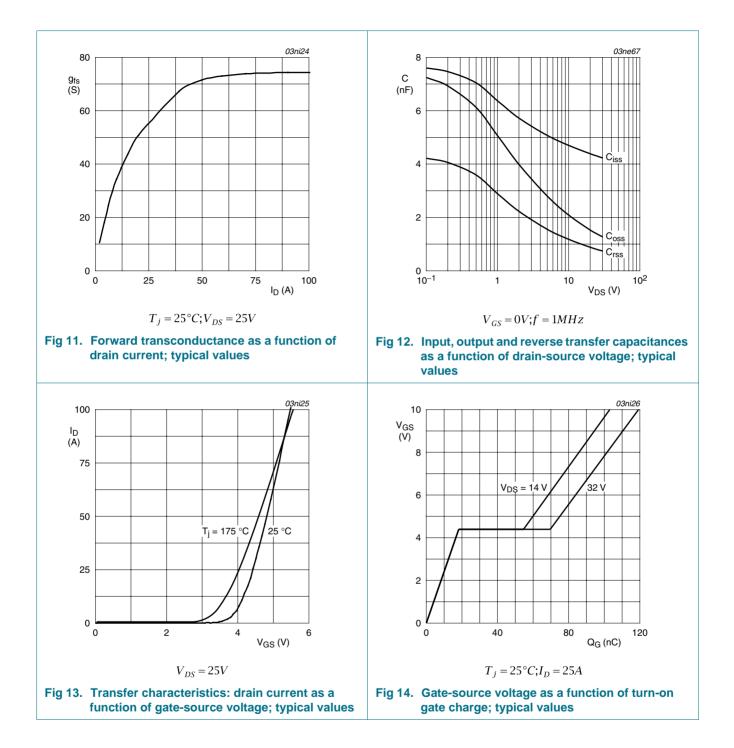
6. Characteristics

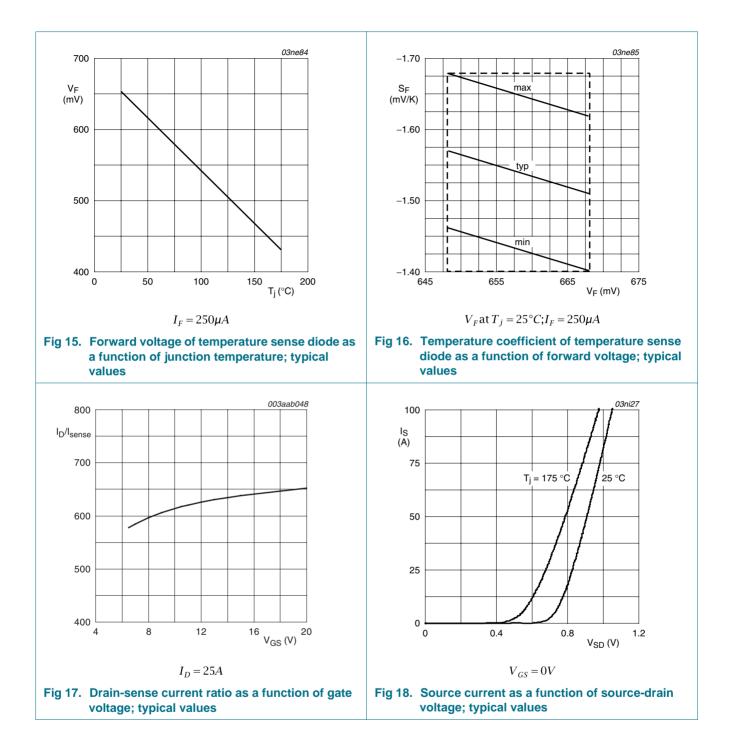
Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
Static cha	racteristics					
V _{(BR)DSS}	drain-source	I_D = 0.25 mA; V_{GS} = 0 V; T_j = 25 °C	40	-	-	V
breakdown voltage		I_D = 0.25 mA; V_{GS} = 0 V; T_j = -55 °C	36	-	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ see Figure 9	2	3	4	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$ see Figure 9	1	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$ see Figure 9	-	-	4.4	V
I _{DSS}	drain leakage current	V_{DS} = 40 V; V_{GS} = 0 V; T_j = 25 °C	-	0.1	10	μA
		$V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$	-	-	250	μΑ
V _{(BR)GSS}	gate-source breakdown voltage	I _G = 1 mA; V _{DS} = 0 V; T _j > -55 °C; T _j < 175 °C	20	22	-	V
		I _G = -1 mA; V _{DS} = 0 V; T _j > -55 °C; T _j < 175 °C	20	22	-	V
I _{GSS}	gate leakage current	$V_{DS} = 0 \text{ V}; V_{GS} = 10 \text{ V}; T_j = 25 \text{ °C}$	-	22	1000	nA
		$V_{DS} = 0 \text{ V}; V_{GS} = -10 \text{ V}; T_j = 25 \text{ °C}$	-	22	1000	nA
		$V_{DS} = 0 \text{ V}; V_{GS} = 10 \text{ V}; T_j = 175 \text{ °C}$	-	-	10	μΑ
		$V_{DS} = 0 \text{ V}; V_{GS} = -10 \text{ V}; T_j = 175 \text{ °C}$	-	-	10	μΑ
DOON	drain-source on-state resistance	V_{GS} = 10 V; I_D = 50 A; T_j = 25 °C; see <u>Figure 7</u> ; see <u>Figure 8</u>	-	4.7	6	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 50 \text{ A}; T_j = 175 ^{\circ}\text{C};$ see <u>Figure 7</u> ; see <u>Figure 8</u>	-	-	11.4	mΩ
V _{F(TSD)}	temperature sense diode forward voltage	I _F = 250 μA; T _j = 25 °C	648	658	668	mV
S _{F(TSD)}	temperature sense diode temperature coefficient	I _F = 250 μA; T _j > -55 °C; T _j < 175 °C	-1.4	-1.54	-1.68	mV/K
V _{F(TSD)hys}	temperature sense diode forward voltage hysteresis	I _F > 125 μΑ; I _F < 250 μΑ; T _j = 25 °C	25	32	50	mV
I _D /I _{sense}	ratio of drain current to sense current	V_{GS} = 10 V; T_j > -55 °C; T_j < 175 °C	585	615	645	
Dynamic of	characteristics					
Q _{G(tot)}	total gate charge	I_D = 25 A; V_{DS} = 32 V; V_{GS} = 10 V;	-	120	-	nC
Q _{GS}	gate-source charge	$T_j = 25 \text{ °C}; \text{ see } Figure 14$	-	19	-	nC
Q _{GD}	gate-drain charge		-	50	-	nC
C _{iss}	input capacitance	$V_{GS} = 0 V; V_{DS} = 25 V; f = 1 MHz;$	-	4300	-	pF
C _{oss}	output capacitance	$T_j = 25 \text{ °C}; \text{ see } Figure 12$	-	1400	-	pF
C _{rss}	reverse transfer capacitance		-	820	-	pF

Table 6.	Characteristics contin	nued				
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
t _{d(on)}	turn-on delay time	$V_{DS} = 30 \text{ V}; \text{ R}_{L} = 1.2 \Omega; \text{ V}_{GS} = 10 \text{ V};$	-	35	-	ns
t _r	rise time	$R_{G(ext)} = 10 \ \Omega; T_j = 25 \ ^{\circ}C$	-	115	-	ns
t _{d(off)}	turn-off delay time		-	155	-	ns
t _f	fall time		-	110	-	ns
L _D	internal drain inductance	measured from upper edge of drain mounting base to centre of die; T _j = 25 °C	-	2.5	-	nH
L _S	internal source inductance	measured from source lead to source bond pad; $T_j = 25 \text{ °C}$	-	7.5	-	nH
Source-d	rain diode					
V _{SD}	source-drain voltage	I _S = 40 A; V _{GS} = 0 V; T _j = 25 °C; see <u>Figure 18</u>	-	0.85	1.2	V
t _{rr}	reverse recovery time	$I_{S} = 20 \text{ A}; \text{ dI}_{S}/\text{dt} = -100 \text{ A}/\mu\text{s}; \text{ V}_{GS} = -10 \text{ V};$	-	96	-	ns
Q _r	recovered charge	V _{DS} = 30 V; T _j = 25 °C	-	224	-	nC









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7. Package outline

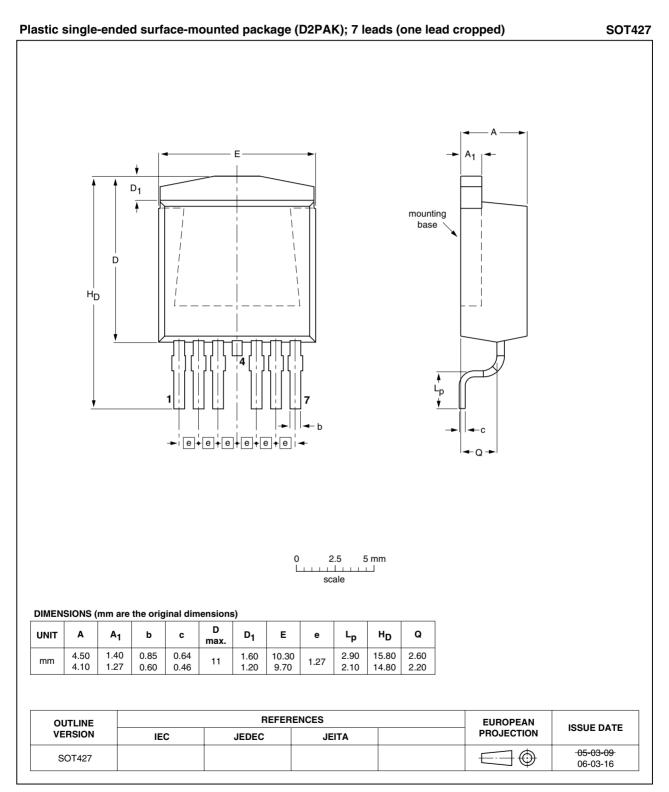


Fig 19. Package outline SOT427 (D2PAK)

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8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK7C06-40AITE_5	20090216	Product data sheet	-	BUK7C06-40AITE_4
Modifications:		t of this data sheet has be of NXP Semiconductors.	en redesigned to compl	y with the new identity
	 Legal texts 	have been adapted to th	e new company name w	/here appropriate.
BUK7C06-40AITE_4	20050623	Product data sheet	-	BUK7C06-40AITE_3
BUK7C06-40AITE_3 (9397 750 15176)	20050616	Product data sheet	-	BUK7C06_40AITE-02
BUK7C06_40AITE-02 (9397 750 12487)	20040129	Product data sheet	-	BUK7C06_40AITE-01
BUK7C06_40AITE-01 (9397 750 09873)	20020717	Product data sheet	-	-

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9.1 Data sheet status

Document status [1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions"

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